

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination KUWAHARA ET AL.	
			Examiner John P. Zimmermann	Art Unit 2861	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,543,874 B2	04-2003	Matsumoto, Nobuo	347/19
*	B	US-6,557,961 B2	05-2003	Cheng et al.	347/9
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	JP 07-081065 A - Yoshiyama et al. - Machine Language Translation <a href="http://www4.ipdl.ipit.go.jp/Tokujitu/tjsogodenk.ipdl">http://www4.ipdl.ipit.go.jp/Tokujitu/tjsogodenk.ipdl</a> Retrieved September 13th, 2007.
	V	JP 08-197738 A - Kurihara et al. - Machine Language Translation <a href="http://www4.ipdl.ipit.go.jp/Tokujitu/tjsogodenk.ipdl">http://www4.ipdl.ipit.go.jp/Tokujitu/tjsogodenk.ipdl</a> Retrieved September 13th, 2007.
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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